Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/717,131	ONISHI ET AL.
Examiner	Art Unit
Ives Wu	1724

SEARCHED					
Class	Subclass	Date	Examiner		
524	502,503	3/15/2007	ΙWU		
524	399,434	7/22/2006	ΙWU		
161	252	7/22/2006	ΙWU		
260	897	7/22/2006	1 WU		
re-work					
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
524	502,503	4/23/2007	I WU		
161	252	4/23/2007	ΙWU		
524	399,434	4/23/2007	ΙWU		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
inventor search - EAST	3/15/2006	I WU		
text serach - EAST	3/15/2007	IWU		
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